



12V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON) max}	Package	I _{D max} T _A = +25°C
	10mΩ @ V _{GS} = 4.5V		11A
	$12m\Omega$ @ $V_{GS} = 2.5V$	LI DENIGOSO C	10
12V	$14m\Omega$ @ $V_{GS} = 1.8V$	U-DFN2020-6 Type E	9A
	18mΩ @ V _{GS} = 1.5V	Type L	8A
	41mΩ @ V _{GS} = 1.2V		5A

Description

This new generation MOSFET has been designed to minimize the onstate resistance (RDS(on)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

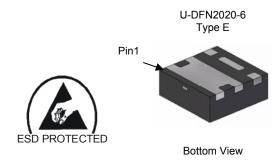
- Load Switching
- Battery Management Application
- Power Management Functions

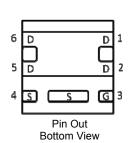
Features

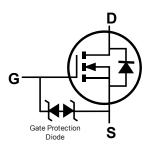
- 0.6mm profile ideal for low profile applications
- PCB footprint of 4mm2
- Low Gate Threshold Voltage
- Fast Switching Speed
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: U-DFN2020-6 Type E
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208 (4)
- Weight: 0.008 grams (approximate)







Equivalent Circuit

Ordering Information (Note 4)

Part Number	Marking	Reel size (inches)	Quantity per reel	
DMN1019UFDE-7	N7	7	3,000	

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html

Marking Information



N7 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: A = 2013) M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016		2017
Code	Υ		Z		Α	[3	С		D		E
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

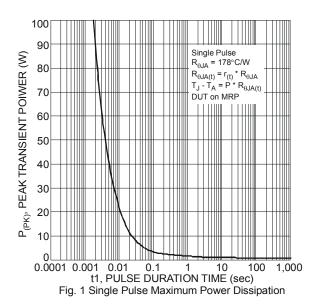


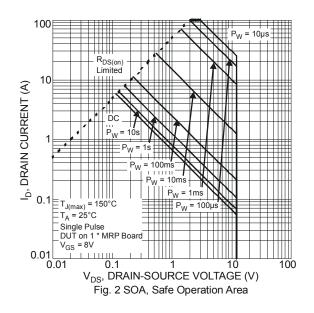
Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage		V_{DSS}	12	V	
Gate-Source Voltage	V_{GSS}	±8	V		
Continuous Drain Current (Note 5) / - 4 5/	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	11 9	Α
Continuous Drain Current (Note 5) V _{GS} = 4.5V	t<5s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	14 11	А
Maximum Continuous Body Diode Current		I _S	3.0	Α	
Pulsed Drain Current (10µs pulse, duty cycle = 1%))	I _{DM}	100	Α	

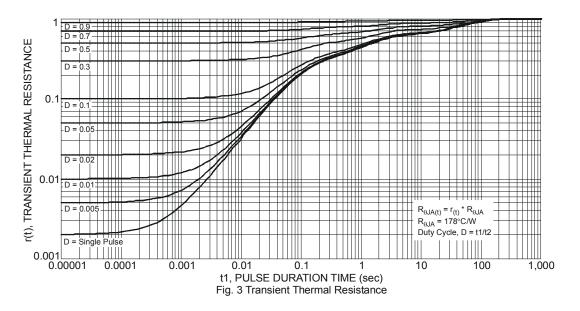
Thermal Characteristics

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	P_{D}	0.69 0.44	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady state t<5s	$R_{ hetaJA}$	182 118	°C/W
Total Power Dissipation (Note 6)	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	P_{D}	2.17 1.38	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady state t<5s	$R_{ hetaJA}$	58 38	°C/W
Thermal Resistance, Junction to Case (Note 6)		$R_{ heta Jc}$	10	
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C









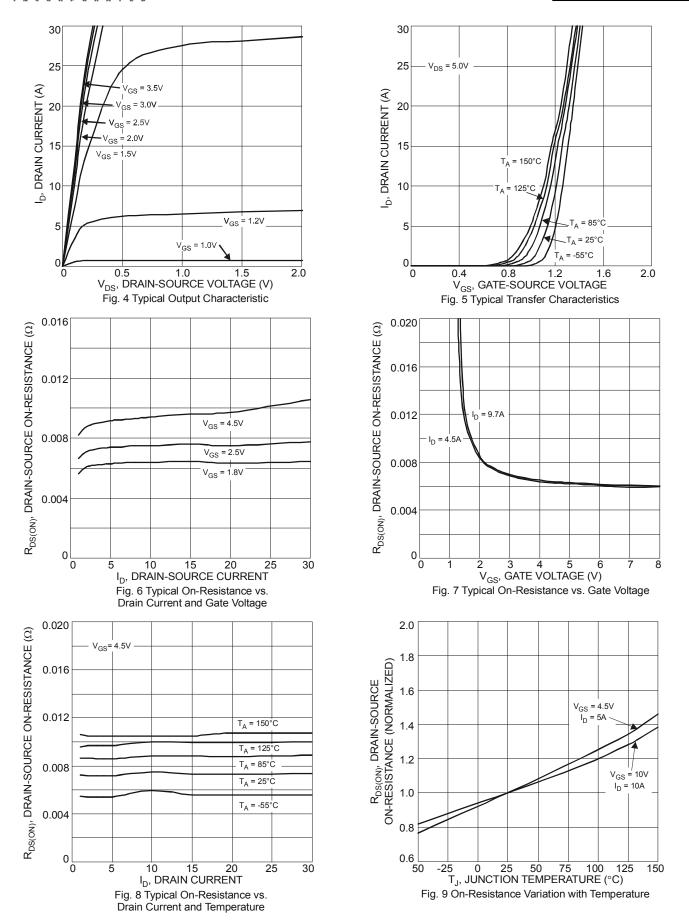
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)	1		1	1	T	
Drain-Source Breakdown Voltage	BV _{DSS}	12	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I_{DSS}	-	_	1	μΑ	$V_{DS} = 12V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}		_	±2	μΑ	$V_{GS} = \pm 8V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)			-	-		
Gate Threshold Voltage	V _{GS(th)}	0.35	_	8.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
			7	10		$V_{GS} = 4.5V, I_D = 9.7A$
			8	12		$V_{GS} = 2.5V, I_D = 9A$
Static Drain-Source On-Resistance	R _{DS (ON)}	_	10	14	mΩ	V _{GS} = 1.8V, I _D = 8.1A
	, ,		14	18		V _{GS} = 1.5V, I _D = 4.5A
			28	41		V _{GS} = 1.2V, I _D = 2.4A
Forward Transfer Admittance	Y _{fs}		28	_	S	V _{DS} = 4V, I _D = 9.7A
Diode Forward Voltage	V _{SD}		0.8	1.2	V	V _{GS} = 0V, I _S = 10A
DYNAMIC CHARACTERISTICS (Note 8)					•	•
Input Capacitance	C _{iss}	_	2425	_		
Output Capacitance	Coss	_	396	_	pF	$V_{DS} = 10V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	375	_		I = 1.0WHZ
Gate Resistance	R_q		1.1	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 8V)	Qg	_	50.6	_		
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	27.3	_	nC	V - 4V I - 40A
Gate-Source Charge	Q _{qs}	_	3.4	_	IIC	$V_{DS} = 4V, I_{D} = 10A$
Gate-Drain Charge	Q _{gd}	_	5.2	_		
Turn-On Delay Time	t _{D(on)}		7.6	_		
Turn-On Rise Time	t _r		22.2	_		$V_{DD} = 4V$, $V_{GS} = 10V$, $I_{D} = 10A$
Turn-Off Delay Time	t _{D(off)}		57.6	_	ns	$R_G = 1\Omega$, $R_L = 0.4\Omega$
Turn-Off Fall Time	t _f	_	16.8	_		

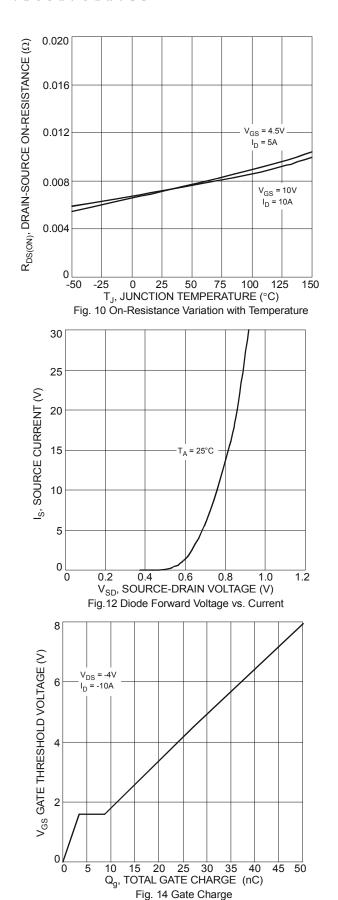
Notes:

- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
- Bevice mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.









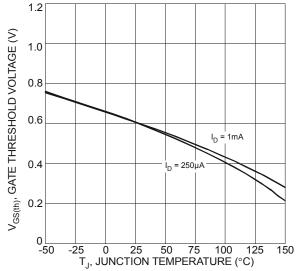
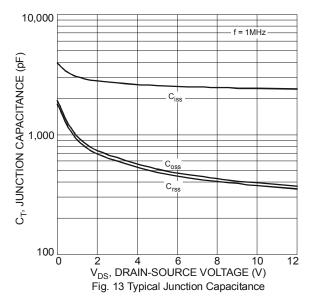
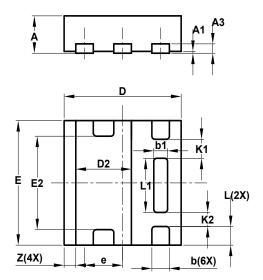


Fig. 11 Gate Threshold Variation vs. Ambient Temperature



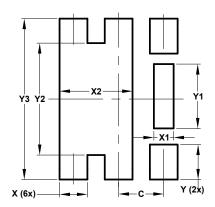


Package Outline Dimensions



	U-DFN2020-6								
	Type E								
Dim	Min	Min Max Typ							
Α	0.57	0.63	0.60						
A1	0	0.05	0.03						
A3			0.15						
b	0.25	0.35	0.30						
b1	0.185	0.285	0.235						
D	1.95	2.05	2.00						
D2	0.85	1.05	0.95						
E	1.95	2.05	2.00						
E2	1.40	1.60	1.50						
е			0.65						
L	0.25	0.35	0.30						
L1	0.82	0.92	0.87						
K1	_	_	0.305						
K2	_	_	0.225						
Ζ	_	_	0.20						
All I	Dimens	ions in	mm						

Suggested Pad Layout



Dimensions	Value (in mm)
C	0.650
X	0.400
X1	0.285
X2	1.050
Υ	0.500
Y1	0.920
Y2	1.600
Y3	2.300



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